### FAIRCHILD SEMICONDUCTOR®

## **FDS7779Z** 30 Volt P-Channel PowerTrench<sup>®</sup> MOSFET

### **General Description**

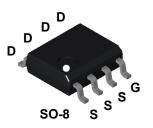
This P-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers, and battery chargers.

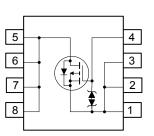
These MOSFETs feature faster switching and lower gate charge than other MOSFETs with comparable  $R_{\text{DS}(\text{ON})}$  specifications.

The result is a MOSFET that is easy and safer to drive (even at very high frequencies), and DC/DC power supply designs with higher overall efficiency.

### Features

- -16 A, -30 V.  $R_{DS(ON)}$  = 7.2 m $\Omega$  @ V<sub>GS</sub> = -10 V  $R_{DS(ON)}$  = 11.5 m $\Omega$  @ V<sub>GS</sub> = -4.5 V
- ESD protection diode (note 3)
- High performance trench technology for extremely low  $R_{\text{DS}(\text{ON})}$
- High power and current handling capability





### Absolute Maximum Ratings T<sub>A</sub>=25°C unless otherwise noted

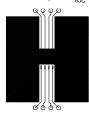
Symbol	Parameter			Ratings	Unit	
/ <sub>DSS</sub>	Drain-Source	e Voltage		-30	V	
/ <sub>GSS</sub>	Gate-Sourc	e Voltage		±25	V	
D	Drain Curre	nt – Continuous	(Note 1a)	-16	A	
		<ul> <li>Pulsed</li> </ul>		-50		
D	Power Diss	pation for Single Opera	ation (Note 1a)	2.5	W	
			(Note 1b)	1.2		
			(Note 1c)	1		
J, T <sub>stg</sub>	Operating a	nd Storage Junction Te	emperature Range	–55 to +150	°C	
Therma २ <sub>0JA</sub>	Charact		mbient (Note 1a)	50	°C/W	
	Thermal Resistance, Junction-to-Ambient         (Note 1a)           Thermal Resistance, Junction-to-Case         (Note 1)			25		
	e Marking	g and Ordering	Information		I	
Device I	Marking	Device	Reel Size	Tape width	Quantity	
	779Z	FDS7779Z	13"	12mm	2500 units	

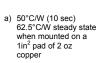
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Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics					
BV <sub>DSS</sub>	Drain–Source Breakdown Voltage	$V_{GS} = 0 V$ , $I_D = -250 \mu A$	-30			V
<u>ΔBV<sub>DSS</sub></u> ΔT <sub>J</sub>	Breakdown Voltage Temperature Coefficient	$I_D$ = -250 µA,Referenced to 25°C		-22		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = -24 V, V_{GS} = 0 V$			-1	μA
I <sub>GSS</sub>	Gate–Body Leakage	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$			±10	μA
On Chara	acteristics (Note 2)					
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, \qquad I_{D} = -250 \ \mu A$	-1	-1.5	-3	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	$I_D$ = -250 µA,Referenced to 25°C		5		mV/°C
R <sub>DS(on)</sub>	Static Drain–Source	$V_{GS} = -10 \text{ V}, \text{ I}_{D} = -16 \text{ A}$		6	7.2	mΩ
	On–Resistance	$V_{GS} = -4.5 \text{ V}, \ I_D = -15 \text{ A}$		9	11.5	
1	On State Drain Current	$V_{GS}$ = -10 V, $I_D$ =-16A, $T_J$ =125°C	50	8	11	^
I <sub>D(on)</sub>	On–State Drain Current Forward Transconductance	$V_{GS} = -4.5 V, V_{DS} = -5 V$ $V_{DS} = -5 V, I_D = -13 A$	-50	43		A S
g <sub>FS</sub>		$V_{DS} = -5 V$ , $I_D = -15 A$		43		3
	Characteristics			3800	1	pF
	Output Capacitance	$V_{DS} = -15 V$ , $V_{GS} = 0 V$ , f = 1.0 MHz		980		pr pF
	Reverse Transfer Capacitance			490		pF
R <sub>G</sub>	Gate Resistance	V <sub>GS</sub> = 15 mV, f = 1.0 MHz		3		Ω
-	g Characteristics (Note 2)			Ū		
	Turn–On Delay Time	$V_{DD} = -15 V$ , $I_{D} = -1 A$ ,		20	36	ns
t <sub>r</sub>	Turn-On Rise Time	$V_{GS} = -10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$		9	18	ns
t <sub>d(off)</sub>	Turn–Off Delay Time	-		100	160	ns
t <sub>f</sub>	Turn–Off Fall Time	-		55	88	ns
Qg	Total Gate Charge	$V_{DS} = -15 V$ , $I_D = -16 A$ ,		70	98	nC
Q <sub>gs</sub>	Gate–Source Charge			10		nC
Q <sub>gd</sub>	Gate–Drain Charge	-		16		nC
Drain-Sc	ource Diode Characteristics	and Maximum Ratings				
l <sub>s</sub>	Maximum Continuous Drain-Source				-2.5	Α
V <sub>SD</sub>	Drain–Source Diode Forward Voltage	$V_{GS} = 0 V$ , $I_S = -2.5 A$ (Note 2)		-0.7	-1.2	V
t <sub>RR</sub>	Reverse Recovery Time	$I_{\rm F} = -16  {\rm A},$		39		ns
Q <sub>RR</sub>	Reverse Recovery Charge	$d_{iF}/d_t = 100 \text{ A}/\mu \text{s}$ (Note 2)		24		nC

Notes:

1. R<sub>6JA</sub> is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R<sub>6JC</sub> is guaranteed by design while R<sub>6CA</sub> is determined by the user's board design.











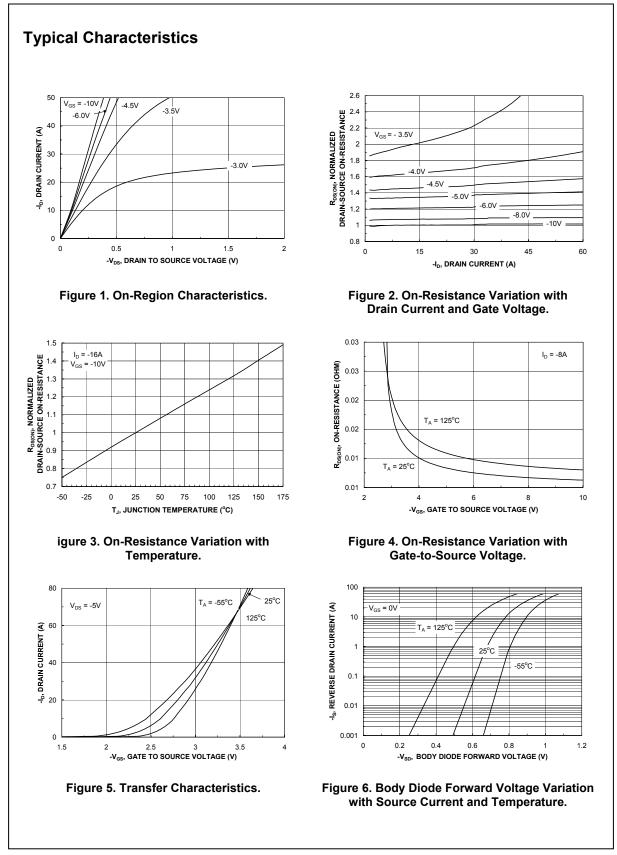
c) 125°C/W when mounted on a minimum pad.

Scale 1 : 1 on letter size paper

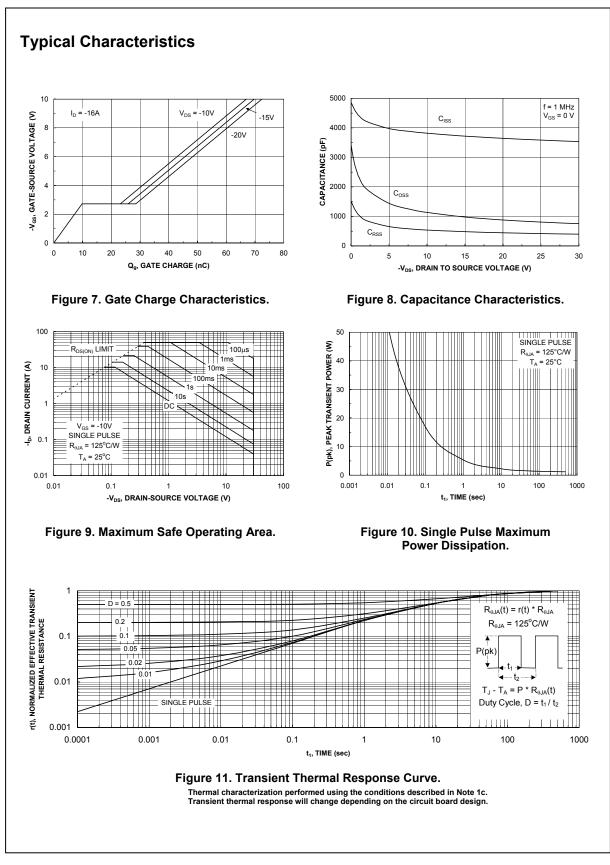
2. Pulse Test: Pulse Width < 300 µs, Duty Cycle < 2.0%

3. The diode connected between the gate and source serves only as protection against ESD. No gate overvoltage rating is implied.

FDS7779Z



# FDS7779Z



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FDS7779Z Rev C1 (W)

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